

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/719,606	CHONG ET AL.	
Examiner		Art Unit		Page 1 of 1
Philip Guyton		2113		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0055172	12-2001	Yip et al.	360/48
*	B	US-5,212,677	05-1993	Shimote et al.	369/53.17
*	C	US-6,223,303	04-2001	Billings et al.	714/8
*	D	US-2002/0191319	12-2002	Liew et al.	360/53
*	E	US-6,557,125	04-2003	Rochat et al.	714/704
*	F	US-7,047,438	05-2006	Smith et al.	714/8
*	G	US-2004/0158769	08-2004	Park, Moon-Chol	714/007
*	H	US-2004/0236985	11-2004	Durica et al.	714/007
*	I	US-6,985,319	01-2006	Yip et al.	360/48
*	J	US-2006/0039252	02-2006	Chu, Sherlock	369/044.32
*	K	US-2006/0156180	07-2006	Kang, Seok-hyeong	714/758
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.